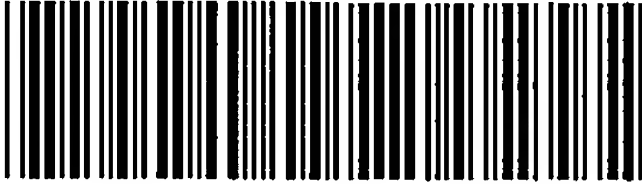


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/647,318	POLITZE ET AL.	
	Examiner	Art Unit	
	Tu T. Nguyen	2877	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	7/6/2006	TN
356/335-->343, 73 250/341.1,341.3,341.8,458.1,227.1 340/628-->630	7/6/2006	TN